

2N80**Power MOSFET****2.4A, 800V N-CHANNEL
POWER MOSFET****■ DESCRIPTION**

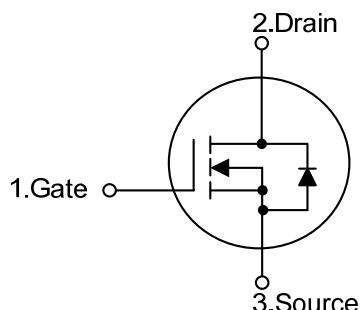
The UTC **2N80** is an N-channel mode power MOSFET using UTC's advanced technology to provide customers planar stripe and DMOS technology. This technology is specialized in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC **2N80** is universally applied in high efficiency switch mode power supply.

■ FEATURES

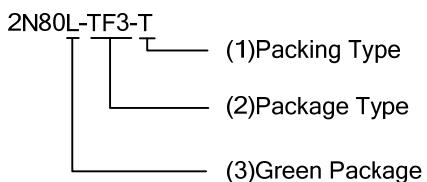
* $R_{DS(on)} < 6.3\Omega$ @ $V_{GS}=10V$, $I_D=1.2A$

* High switching speed

■ SYMBOL**■ ORDERING INFORMATION**

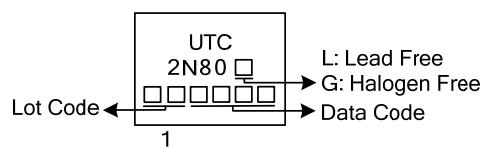
Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
2N80L-TF3-T	2N80G-TF3-T	TO-220F	G	D	S	Tube
2N80L-TM3-R	2N80G-TM3-R	TO-251	G	D	S	Tube
2N80L-TN3-R	2N80G-TN3-R	TO-252	G	D	S	Tape Reel
2N80L-TND-R	2N80G-TND-R	TO-252D	G	D	S	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source



(1) T: Tube, R: Tape Reel
(2) TF3: TO-220F, TM3: TO-251, TN3: TO-252
TND: TO-252D
(3) L: Lead Free, G: Halogen Free and Lead Free

■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	800	V
Gate-Source Voltage		V_{GSS}	± 30	V
Avalanche Current (Note 2)		I_{AR}	2.4	A
Drain Current	Continuous	I_D	2.4	A
	Pulsed (Note 2)	I_{DM}	9.6	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	180	mJ
	Repetitive (Note 2)	E_{AR}	8.5	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.0	V/ns
Power Dissipation	TO-220F	P_D	24	W
	TO-251/TO-252/TO-252D		43	
Junction Temperature		T_J	+150	$^\circ\text{C}$
Storage Temperature		T_{STG}	-55~+150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.
 Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 2. Repetitive Rating: Pulse width limited by maximum junction temperature
 3. $L = 59\text{mH}$, $I_{AS} = 2.4\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$
 4. $I_{SD} \leq 2.4\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220F	θ_{JA}	62.5	$^\circ\text{C/W}$
	TO-251/TO-252/TO-252D		110	
Junction to Case	TO-220F	θ_{JC}	5.2	$^\circ\text{C/W}$
	TO-251/TO-252/TO-252D		2.85	

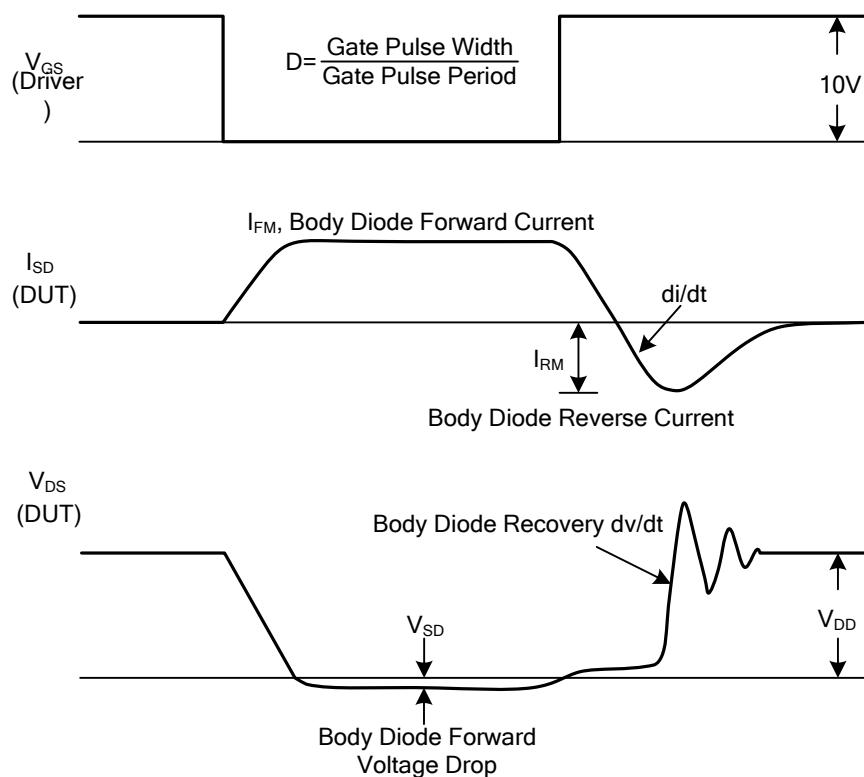
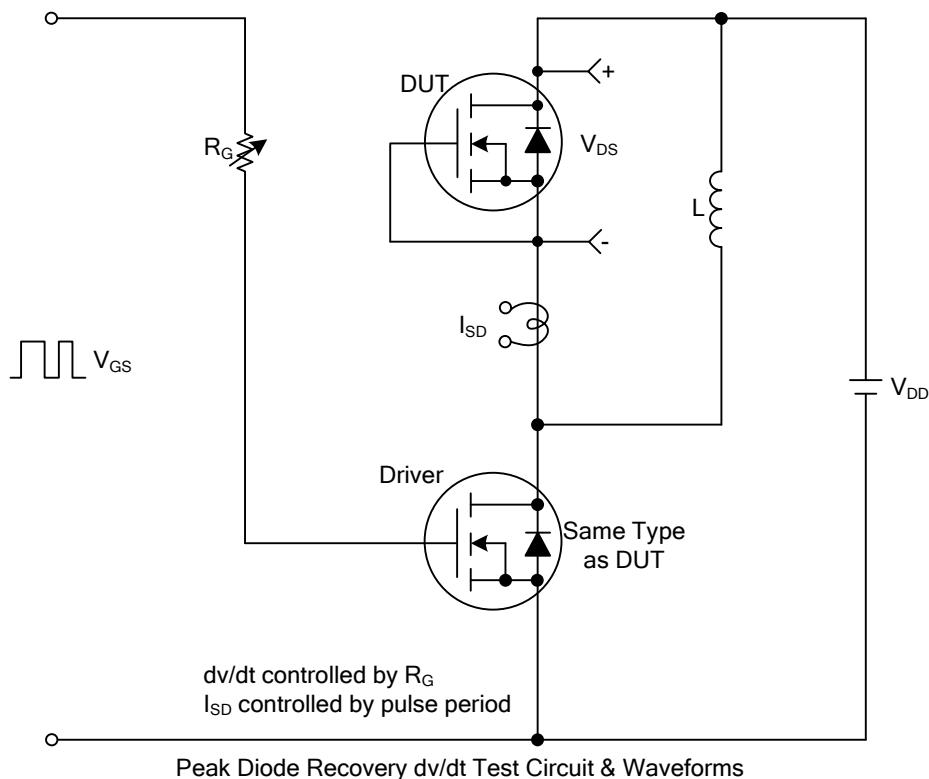
■ ELECTRICAL CHARACTERISTICS ($T_c=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	800			V
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $I_D=250\mu\text{A}$		0.9		$\text{V}/^\circ\text{C}$
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=800\text{V}, V_{GS}=0\text{V}$		10		μA
		$V_{DS}=640\text{V}, T_c=125^\circ\text{C}$		100		
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=+30\text{V}, V_{DS}=0\text{V}$		+100		nA
		$V_{GS}=-30\text{V}, V_{DS}=0\text{V}$		-100		nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	3.0		5.0	V
Static Drain-Source On-State Resistance	$R_{DS(\text{ON})}$	$V_{GS}=10\text{V}, I_D=1.2\text{A}$		4.8	6.3	Ω
Forward Transconductance (Note 1)	g_{FS}	$V_{DS}=50\text{V}, I_D=1.2\text{A}$		2.65		S
DYNAMIC PARAMETERS						
Input Capacitance	C_{ISS}	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1.0\text{MHz}$		550	650	pF
Output Capacitance	C_{OSS}			45	60	pF
Reverse Transfer Capacitance	C_{RSS}			7	9	pF
SWITCHING PARAMETERS						
Turn-ON Delay Time	$t_{D(\text{ON})}$	$V_{GS}=10\text{V}, V_{DD}=30\text{V}, I_D=0.5\text{A}, R_G=25\Omega$ (Note 1,2)		50		ns
Rise Time	t_R			60		ns
Turn-OFF Delay Time	$t_{D(\text{OFF})}$			80		ns
Fall-Time	t_F			40		ns
Total Gate Charge	Q_G	$V_{GS}=10\text{V}, V_{DS}=50\text{V}, I_D=1.3\text{A}, I_G=100\mu\text{A}$ (Note 1,2)		18	28	nC
Gate to Source Charge	Q_{GS}			6		nC
Gate to Drain Charge	Q_{GD}			5		μC
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Continuous Drain-Source Diode Forward Current	I_S				2.4	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				9.6	A
Drain-Source Diode Forward Voltage	V_{SD}	$I_S=2.4\text{A}, V_{GS}=0\text{V}$			1.4	V
Reverse Recovery Time (Note 1)	t_{RR}	$I_S=2.4\text{A}, V_{GS}=0\text{V}, dI/dt=100\text{A}/\mu\text{s}$		480		ns
Reverse Recovery Charge (Note 1)	Q_{RR}			2.0		μC

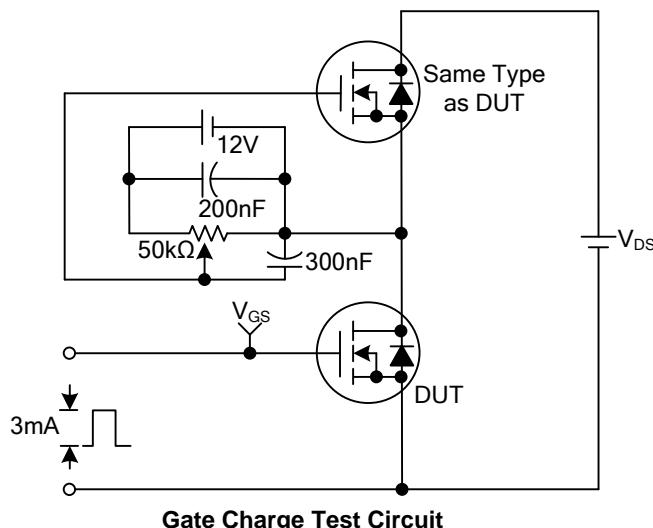
Notes: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$

2. Essentially independent of operating temperature

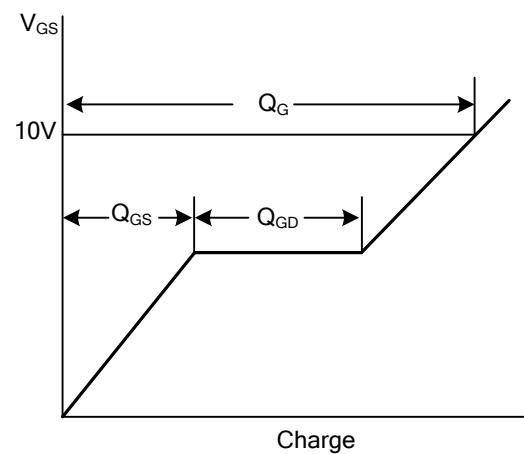
■ TEST CIRCUITS AND WAVEFORMS



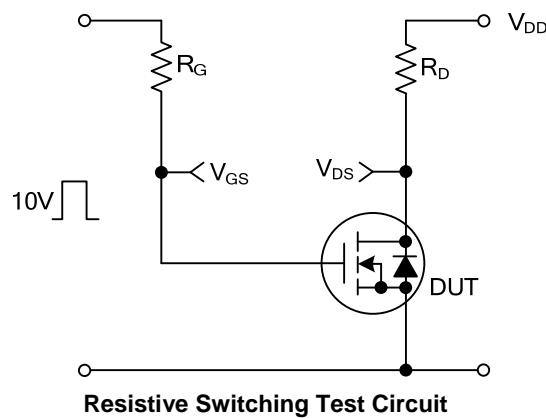
■ TEST CIRCUITS AND WAVEFORMS(Cont.)



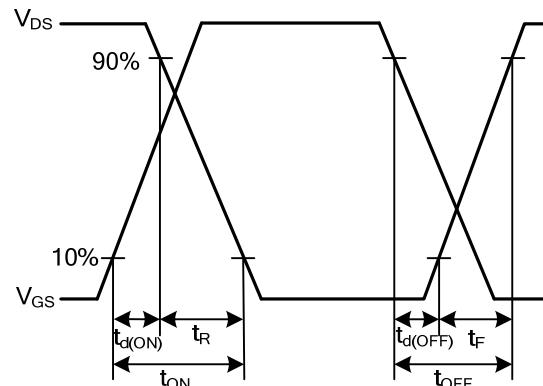
Gate Charge Test Circuit



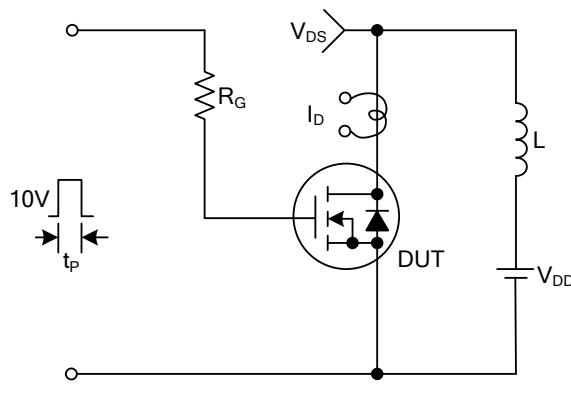
Gate Charge Waveforms



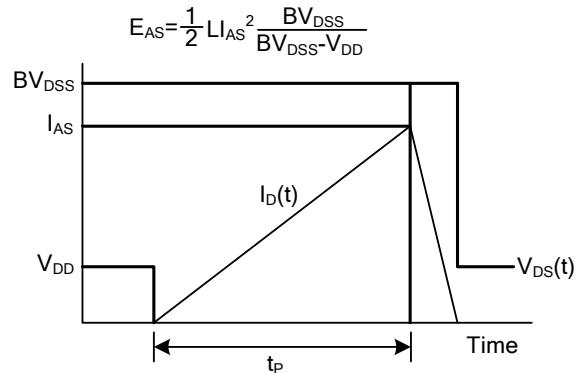
Resistive Switching Test Circuit



Resistive Switching Waveforms

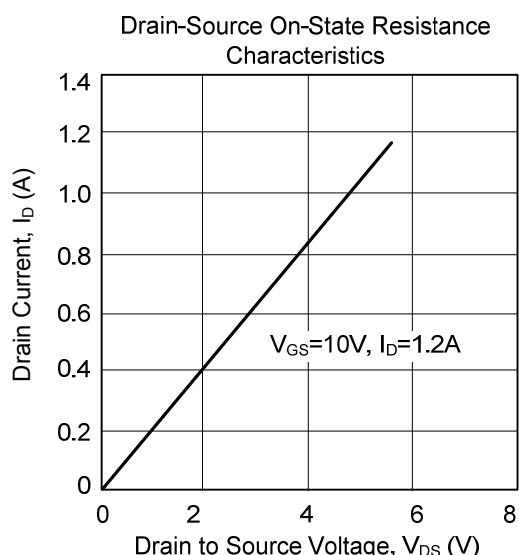
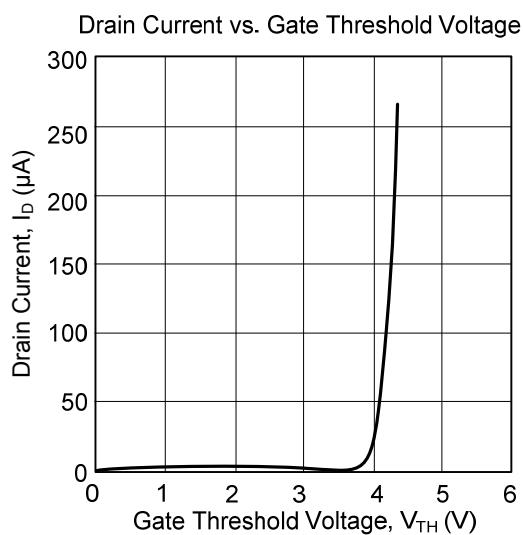
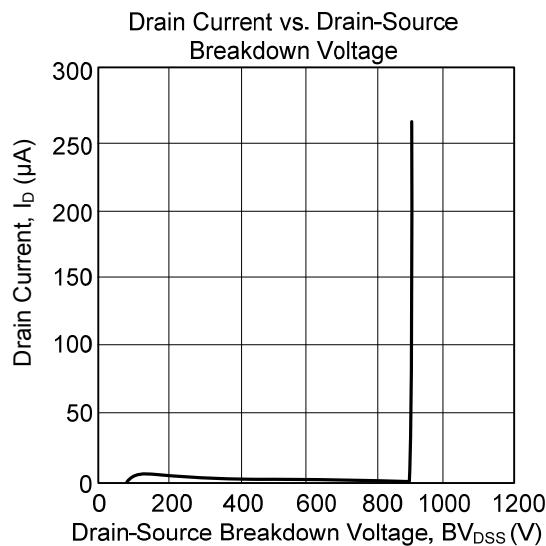


Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS



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